

Erratum

Erratum to “Merged-Sampling Mask R-CNN With Random Proposal Expansion for Particle Measurement of SEM Images of Molecular Sieve Catalysts”

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In the above article [1], row 3 paragraph 3 in Section III-B, the width w equals to $x_2 - x_1$ as it is shown in Fig. 4.

REFERENCES

- [1] J. Xin, Z. Wei, M. Yang, X. Peng, and W. Du, “Merged-sampling mask R-CNN with random proposal expansion for particle measurement of SEM images of molecular sieve catalysts,” *IEEE Trans. Instrum. Meas.*, vol. 70, pp. 1–13, 2021, doi: [10.1109/TIM.2021.3124835](https://doi.org/10.1109/TIM.2021.3124835).

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